# **BUK7905-40ATE**



## N-channel TrenchPLUS standard level FET

Rev. 02 — 10 February 2009

**Product data sheet** 

### 1. Product profile

#### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS diodes for temperature sensing and ElectroStatic Discharge (ESD) protection. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

#### 1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes
- Low conduction losses due to low on-state resistance
- Q101 compliant
- Suitable for standard level gate drive sources

#### 1.3 Applications

Electrical Power Assisted Steering (EPAS)

Variable Valve Timing for engines

#### 1.4 Quick reference data

Table 1. Quick reference

Typ -	<b>Max</b> 40	Unit V
-	40	V
4.5	5	mΩ
-1.54	-1.68	mV/K
658	668	mV
32	50	mV
	-1.54 658	-1.54 -1.68 658 668



## 2. Pinning information

**Table 2.** Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	Α	anode	mb	D A
3	D	drain		G ← I □ T T
4	K	cathode		(太
5	S	source	1	
mb	D	mounting base; connected to drain	1 2 3 4 5 SOT263B (TO-220)	S K mbl317

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK7905-40ATE	TO-220	plastic single-ended package; heatsink mounted; 1 mounting hole; 5-lead TO-220	SOT263B

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	40	V
$V_{GS}$	gate-source voltage			-20	20	V
$I_D$	drain current	T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; see <u>Figure 2</u> ; see <u>Figure 3</u>	[1]	-	155	Α
			[2]	-	75	Α
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 2</u>	[2]	-	75	Α
$I_{DM}$	peak drain current	$T_{mb} = 25 \text{ °C}$ ; $t_p \le 10 \mu\text{s}$ ; pulsed; see Figure 3		-	620	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>		-	272	W
I <sub>GS(CL)</sub>	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5 \text{ ms}$ ; $\delta = 0.01$		-	50	mA
$V_{isol(FET-TSD)}$	FET to temperature sense diode isolation voltage			-100	100	V
$T_{stg}$	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drai	n diode					
Is	source current	$T_{mb} = 25  ^{\circ}C$	[1]	-	155	Α
			[2]	-	75	Α
$I_{SM}$	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	620	Α
Avalanche r	uggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 75 A; $V_{sup} \le 40$ V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	1.46	J
Electrostation	c discharge					
V <sub>esd</sub>	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ		-	6	kV

<sup>[1]</sup> Current is limited by power dissipation chip rating.

<sup>[2]</sup> Continuous current is limited by package.

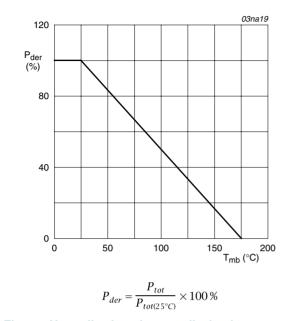


Fig 1. Normalized total power dissipation as a function of mounting base temperature

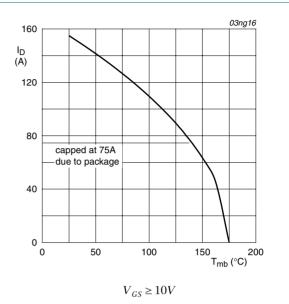


Fig 2. Continuous drain current as a function of mounting base temperature

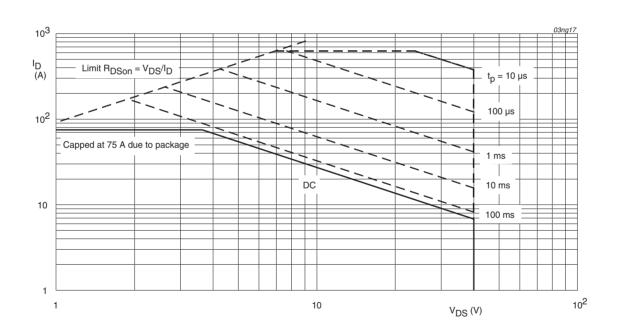


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 $T_{mb} = 25$ °C; $I_{DM}$ is single pulse

### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W

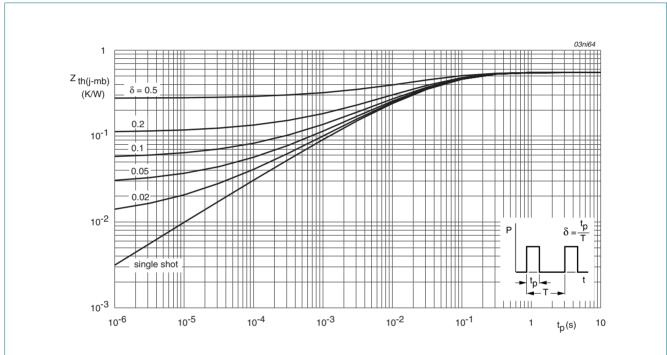


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	40	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	36	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 9	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 9	1	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see Figure 9	-	-	4.4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.1	10	μΑ
		V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 175 °C	-	-	250	μΑ
$V_{(BR)GSS}$ gate-source break voltage	gate-source breakdown voltage	$I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j \le 175 \text{ °C};$ $T_j \ge -55 \text{ °C}$	20	22	-	V
		$I_G = -1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j \le 175 \text{ °C};$ $T_j \ge -55 \text{ °C}$	20	22	-	V
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	22	1000	nA
		V <sub>DS</sub> = 0 V; V <sub>GS</sub> = -10 V; T <sub>j</sub> = 25 °C	-	22	1000	nA
		V <sub>DS</sub> = 0 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 175 °C	-	-	10	μΑ
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 175 \text{ °C}$	-	-	10	μΑ
$R_{DSon}$	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 50 A; $T_j$ = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	4.5	5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 7; see Figure 8	-	-	9.5	mΩ
$V_{F(TSD)}$	temperature sense diode forward voltage	$I_F = 250 \ \mu A; T_j = 25 \ ^{\circ}C$	648	658	668	mV
$S_{F(TSD)}$	temperature sense diode temperature coefficient	$I_F = 250 \ \mu A; T_j \ge -55 \ ^{\circ}C; T_j \le 175 \ ^{\circ}C$	-1.4	-1.54	-1.68	mV/ł
$V_{F(TSD)hys}$	temperature sense diode forward voltage hysteresis	$I_F \le 250 \ \mu A; I_F \ge 125 \ \mu A; T_j = 25 \ ^{\circ}C$	25	32	50	mV
Dynamic o	haracteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$	-	118	-	nC
Q <sub>GS</sub>	gate-source charge	T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	16	-	nC
Q <sub>GD</sub>	gate-drain charge		-	57	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	4500	-	рF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 12</u>	-	1500	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	960	-	pF

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 30 V; $R_L$ = 1.2 $\Omega;V_{GS}$ = 10 V;	-	35	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	115	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	155	-	ns
t <sub>f</sub>	fall time		-	110	-	ns
L <sub>D</sub>	internal drain inductance	from upper edge of mounting base to centre of die; $T_j = 25$ °C	-	2.5	-	nΗ
L <sub>S</sub>	internal source inductance	from source lead to source bond pad; $T_j = 25  ^{\circ}\text{C}$	-	7.5	-	nH
Source-dr	ain diode					
$V_{SD}$	source-drain voltage	$I_S = 40 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 17	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = -10 \text{ V};$	-	96	-	ns
$Q_r$	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	224	-	nC

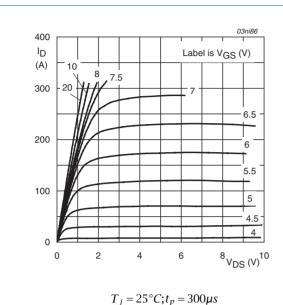


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

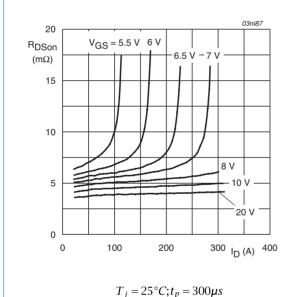
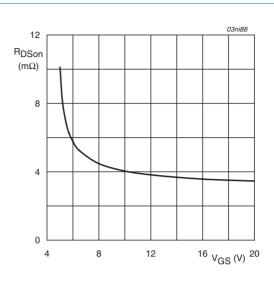
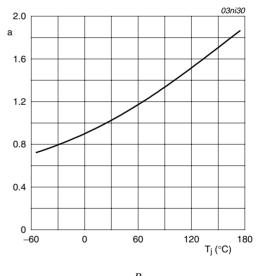


Fig 7. Drain-source on-state resistance as a function of drain current; typical values



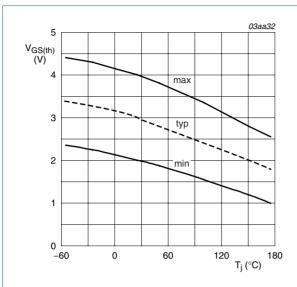
 $T_j = 25^{\circ}C; I_D = 50A$ 

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



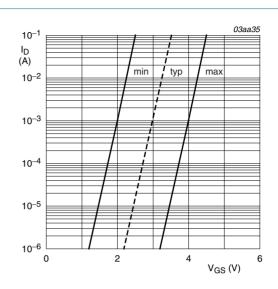
 $a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C}}$ 

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



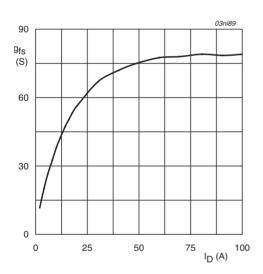
$$I_D = 1 \, mA; V_{DS} = V_{GS}$$

Fig 9. Gate-source threshold voltage as a function of junction temperature



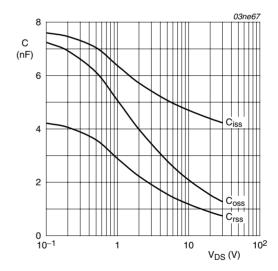
$$T_{j} = 25 \,^{\circ}C; V_{DS} = 5V$$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



 $T_i = 25^{\circ}C; V_{DS} = 25V$ 

Fig 11. Forward transconductance as a function of drain current; typical values



$$V_{GS} = 0V; f = 1MHz$$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

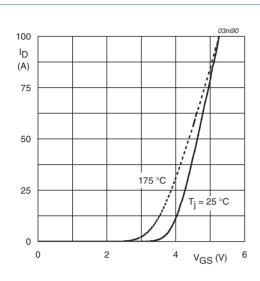


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values

 $V_{DS} = 25V$ 

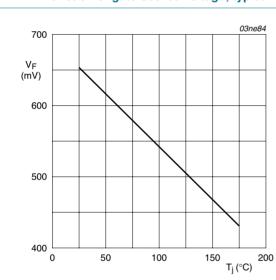
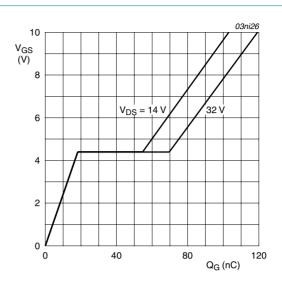


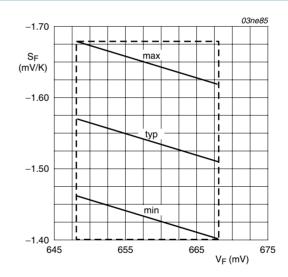
Fig 15. Forward voltage of temperature sense diode as a function of junction temperature; typical values

 $I_F = 250 \mu A$ 



 $T_i = 25^{\circ}C; I_D = 25A$ 

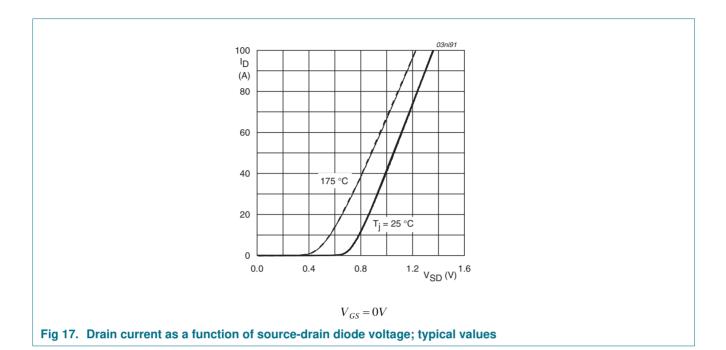
Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values



 $V_F$  at  $T_j = 25^{\circ}C$ ;  $I_F = 250 \mu A$ 

Fig 16. Temperature coefficient of temperature sense diode as a function of forward voltage; typical values

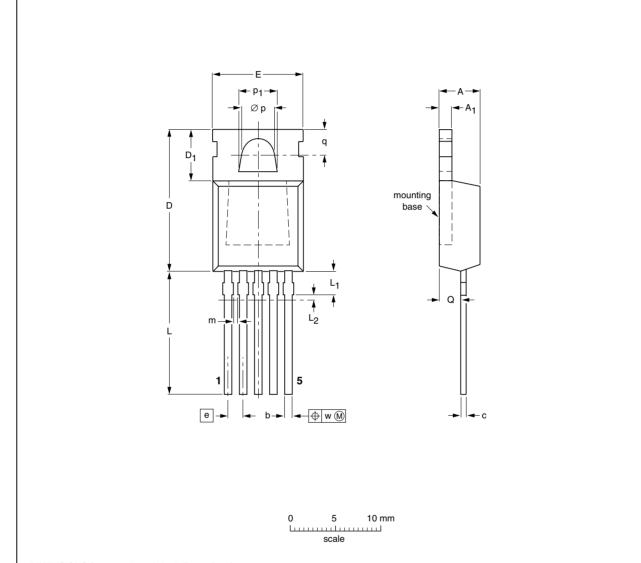
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### 7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 5-lead TO-220

SOT263B



#### DIMENSIONS (mm are the original dimensions)

UNIT	A	A <sub>1</sub>	b	С	D	D <sub>1</sub>	E	е	L	L <sub>1</sub> <sup>(1)</sup>	L <sub>2</sub> <sup>(2)</sup>	m	Øp	p <sub>1</sub>	q	Q	w
mm	4.5 4.1	1.39 1.27	0.85 0.70	0.7 0.4	15.8 15.2	6.4 5.9	10.3 9.7	1.7	15.0 13.5	2.4 1.6	0.5	0.8 0.6	3.8 3.6	4.3 4.1	3.0 2.7	2.6 2.2	0.4

#### Notes

- 1. Terminal dimensions are uncontrolled in this zone.
- 2. Positional accuracy of the terminals is controlled in this zone.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT263B		5-lead TO-220			01-01-11

Fig 18. Package outline SOT263B (TO-220)

## **Revision history**

#### Table 7. **Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7905-40ATE_2	20090210	Product data sheet	-	BUK71_7905_40ATE-01
Modifications:	guidelines of Legal texts	of this data sheet has bee of NXP Semiconductors. have been adapted to the er BUK7905-40ATE separa	new company name whe	ere appropriate.
BUK71_7905_40ATE-01 (9397 750 11694)	20030820	Product data sheet	-	-

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### 9. Legal information

#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nexperia.com.

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# **BUK7905-40ATE**

### N-channel TrenchPLUS standard level FET

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